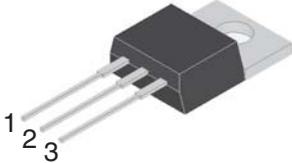
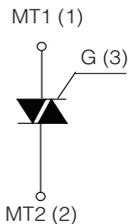


INSULATED LOGIC LEVEL TRIAC

<p style="text-align: center; font-weight: bold; font-size: 1.2em;">INSULATED TO-220AB</p> <div style="text-align: center; margin-top: 20px;">  </div> <div style="text-align: center; margin-top: 20px;">  </div>	<table style="width: 100%; border-collapse: collapse;"> <tr> <td style="width: 50%; padding: 5px;">On-State Current 12 Amp</td> <td style="width: 50%; padding: 5px;">Gate Trigger Current ≤ 10 mA (08) ≤ 5 mA (04)</td> </tr> <tr> <td colspan="2" style="text-align: center; padding: 5px;">Off-State Voltage 200 V ÷ 800 V</td> </tr> </table> <p>FEATURES</p> <ul style="list-style-type: none"> • Glass/passivated die junctions • Provides voltage insulated tab (rated at 2500V RMS) • Medium current Triac • Low thermal resistance • High surge current capability • Low forward voltage drop • Solder dip 260°C, 10s • Component in accordance to RoHS 2011/65/EU and WEEE 2002/96/EC • Meets MSL level 3, per J-STD-020, LF maximum peak of 260° C • Certified compliance of UL 1557 Standard for Electrically Isolated Semiconductors. Fille reference E320541, Vol. 3 <div style="text-align: right; margin-top: 10px;">   RoHS COMPLIANT </div> <p>MECHANICAL DATA</p> <ul style="list-style-type: none"> • Case: INSULATED TO-220AB. Epoxy meets UL 94V-0 flammability rating. • Polarity: As marked on the body. • Terminals: Matte tin plated leads, solderable per MIL-STD-750 Method 2026, J-STD-002 and JESD22-B102. Consumer grade, meets JESD 201 class 1A whisker test. <p>TYPICAL APPLICATIONS</p> <p>Logic level versions are designed to interface directly with low power drivers such as microcontrollers.</p>	On-State Current 12 Amp	Gate Trigger Current ≤ 10 mA (08) ≤ 5 mA (04)	Off-State Voltage 200 V ÷ 800 V	
On-State Current 12 Amp	Gate Trigger Current ≤ 10 mA (08) ≤ 5 mA (04)				
Off-State Voltage 200 V ÷ 800 V					

Maximun Ratings and Electrical Characteristics at 25°C

SYMBOL	PARAMETER	CONDITIONS	Value	Unit
$I_{T(RMS)}$	RMS On-state Current (full sine wave)	All Conduction Angle, $T_c = 90^\circ C$	12	A
I_{TSM}	Non-repetitive On-State Current	Full Cycle, 60 Hz ($t = 16.7$ ms)	125	A
I_{TSM}	Non-repetitive On-State Current	Full Cycle, 50 Hz ($t = 20$ ms)	120	A
I^2t	Fusing Current	$t_p = 10$ ms, Half Cycle	72	A ² s
I_{GM}	Peak Gate Current	20 μ s max. $T_j = 125^\circ C$	4	A
$P_{G(AV)}$	Average Gate Power Dissipation	$T_j = 125^\circ C$	1	W
di/dt	Critical rate of rise of on-state current	$I_G = 2x I_{GT}$, $t_r \leq 100$ ns $f = 120$ Hz, $T_j = 125^\circ C$	50	A/ μ s
T_j	Operating Temperature		(-40 +125)	°C
T_{stg}	Storage Temperature		(-40 +125)	°C
T_{sld}	Soldering Temperature	10s max	260	°C
V_{iso}	R.M.S. isolation voltage 50/60 Hz sinusoidal waveform		2.500	Vac

SYMBOL	PARAMETER	VOLTAGE				Unit
		B	D	M	N	
V_{DRM}/V_{RRM}	Repetitive Peak Off State Voltage	200	400	600	800	V

INSULATED LOGIC LEVEL TRIAC

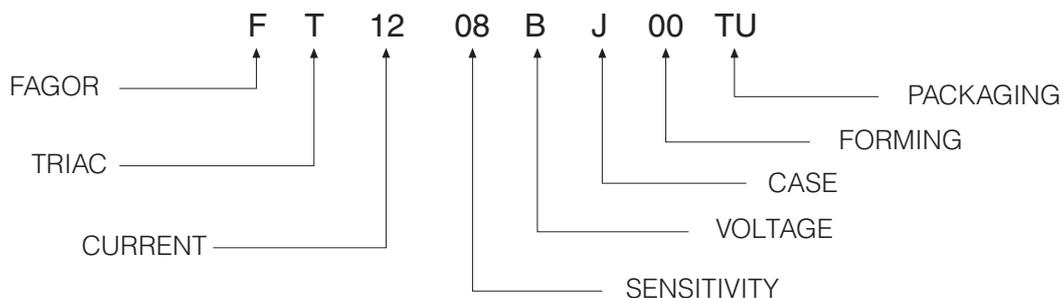
Electrical Characteristics at Tamb = 25 °C

SYMBOL	PARAMETER	CONDITIONS	Quadrant		SENSITIVITY		Unit
					04	08	
I _{GT} ⁽¹⁾	Gate Trigger Current	V _D = 12 V _{DC} , R _L = 33Ω, T _j = 25 °C	Q1÷Q3	MAX	5	10	mA
			Q4	MAX	-	-	mA
V _{GT}	Gate Trigger Voltage	V _D = 12 V _{DC} , R _L = 33Ω, T _j = 25 °C	Q1÷Q3	MAX	1.3	1.3	V
			Q1÷Q4	MAX	-	-	V
V _{GD}	Gate Non Trigger Voltage	V _D = V _{DRM} , R _L = 3.3 KΩ, T _j = 125 °C	Q1÷Q3	MIN	0.2	0.2	V
			Q1÷Q4	MIN	-	-	V
I _H ⁽²⁾	Holding Current	I _T = 100 mA, Gate open, T _j = 25 °C		MAX	15		mA
I _L	Latching Current	I _G = 1.2 I _{GT} , T _j = 25 °C	Q1,Q3	MAX	10	25	mA
			Q2	MAX	15	30	mA
dV/dt ⁽²⁾	Critical Rate of Voltage Rise	V _D = 0.67 x V _{DRM} , Gate open T _j = 125 °C		MIN	20	40	V/μs
(dI/dt) _c ⁽²⁾	Critical Rate of Current Rise	(dv/dt) _c = 0.1 V/μs T _j = 125 °C (dv/dt) _c = 10 V/μs T _j = 125 °C		MIN	3.5	6.5	A/ms
				MIN	1	2.9	A/ms
V _{TM} ⁽²⁾	On-state Voltage	I _T = 17 Amp, t _p = 380 μs, T _j = 25 °C		MAX	1.55		V
V _{t(o)} ⁽²⁾	Threshold Voltage	T _j = 125 °C		MAX	0.85		V
r _d ⁽²⁾	Dynamic resistance	T _j = 125 °C		MAX	35		mΩ
I _{DRM} /I _{RRM}	Off-State Leakage Current	V _D = V _{DRM} , T _j = 125 °C V _R = V _{RRM} , T _j = 25 °C		MAX	1		mA
				MAX	5		μA
R _{th(j-c)}	Thermal Resistance Junction-Case	for AC 360° conduction angle			2.3		°C/W
R _{th(j-a)}	Thermal Resistance Junction-Ambient				60		°C/W

(1) Minimum I_{GT} is guaranteed at 5% of I_{GT} max.

(2) For either polarity of electrode MT2 voltage with reference to electrode MT1.

Part Number Information



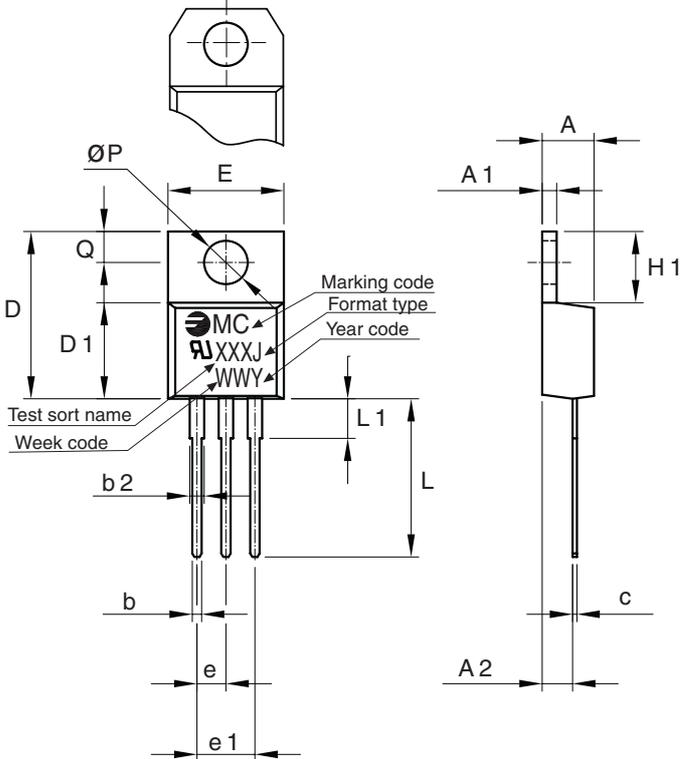
INSULATED LOGIC LEVEL TRIAC

Ordering information

PREFERRED P/N	PACKAGE CODE	DELIVERY MODE	BASE QUANTITY	UNIT WEIGHT (g)
FT1208MJ 00TU	TU	TUBE	1000	2.30

Package Outline Dimensions: (mm) INSULATED TO-220AB

Optional with chamfer



The drawing shows a top view and a side view of the TO-220AB package. The top view includes dimensions: $\varnothing P$ (lead diameter), E (lead spacing), D (body diameter), Q (lead length), $D1$ (body diameter), L (total length), b (lead width), e (lead pitch), $b2$ (lead width), and $e1$ (lead pitch). The side view shows dimensions: A (body width), $A1$ (lead width), $A2$ (lead width), $H1$ (lead height), and c (lead thickness). Marking details include: MC (Marking code), XXXJ (Format type), WWY (Year code), Test sort name, and Week code.

REF.	DIMENSIONS	
	Millimeters	
	Min.	Max.
A	4.32	4.62
A1	1.21	1.29
A2	2.40	2.70
b	0.80	0.83
b2	1.40	--
c	0.42	0.48
D	15.5	15.68
D1	9.26	9.42
E	10.08	10.24
e	2.54	2.54
e1	5.08	5.08
H1	6.24	6.26
L	12.81	13.81
L1	3.28	4.17
P	3.70	3.80
Q	2.75	2.85

Mounting Torque

0.8 N.m

INSULATED LOGIC LEVEL TRIAC

Ratings and Characteristics (Ta 25 °C unless otherwise noted)

Fig. 1: Maximum power dissipation versus RMS on-state current (full cycle).

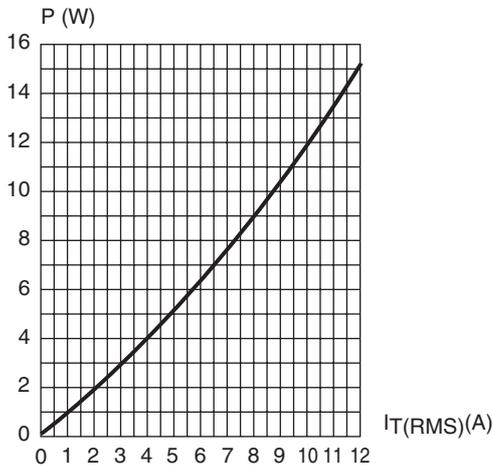


Fig. 2: RMS on-state current versus case temperature (full cycle).

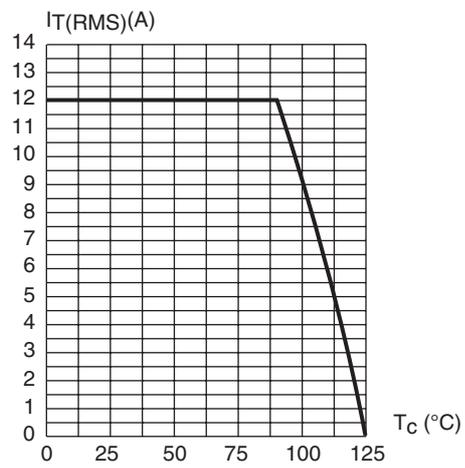


Fig. 3: Relative variation of thermal impedance versus pulse duration.

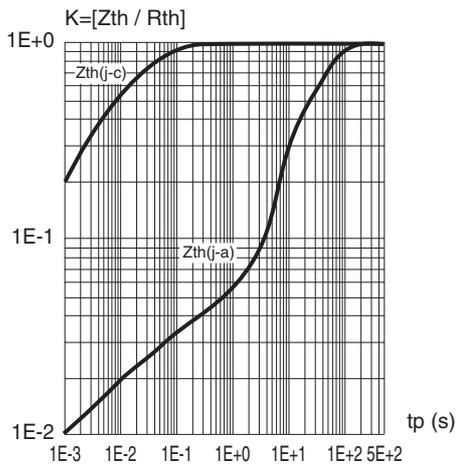


Fig. 4: On-state characteristics (maximum values)

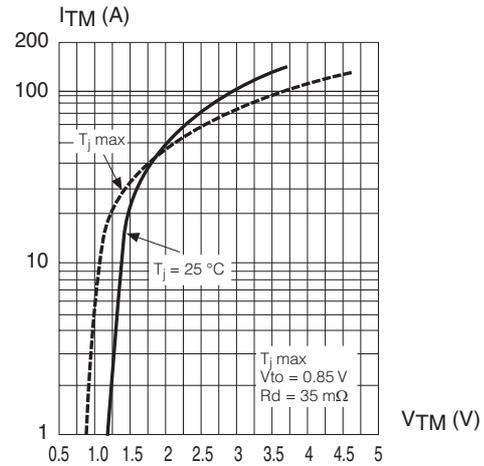


Fig. 5: Surge peak on-state current versus number of cycles

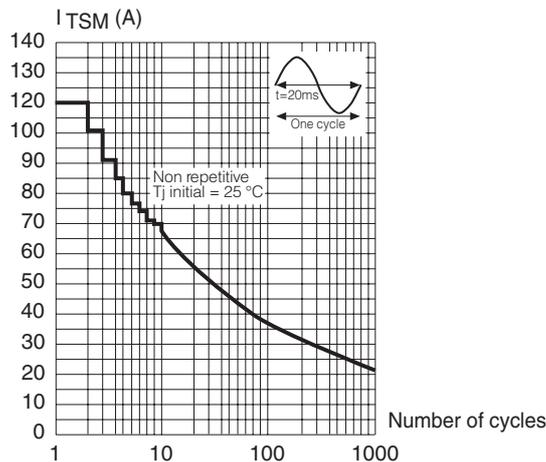
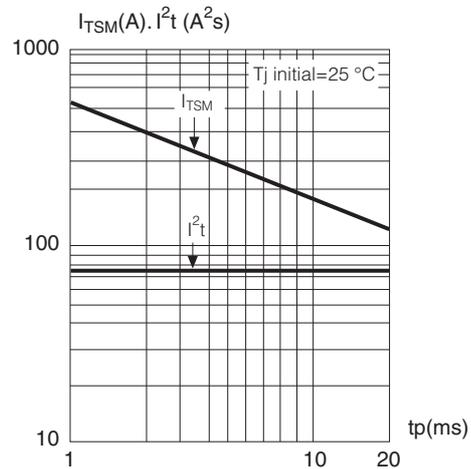


Fig. 6: Non repetitive surge peak on-state current for a sinusoidal pulse with width: tp < 20 ms, and corresponding value of I²t.



INSULATED LOGIC LEVEL TRIAC

Ratings and Characteristics (Ta 25 °C unless otherwise noted)

Fig. 7: Relative variation of gate trigger current, holding current and latching versus junction temperature (typical values)

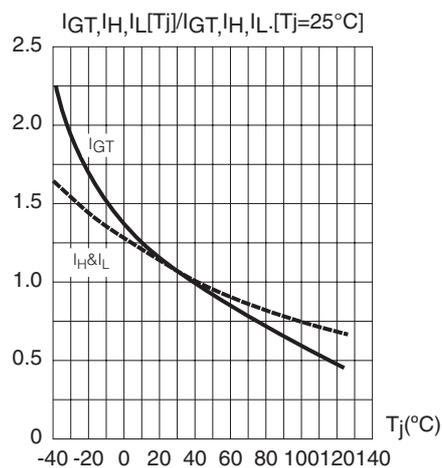


Fig. 8: Relative variation of critical rate of decrease of main current versus junction temperature

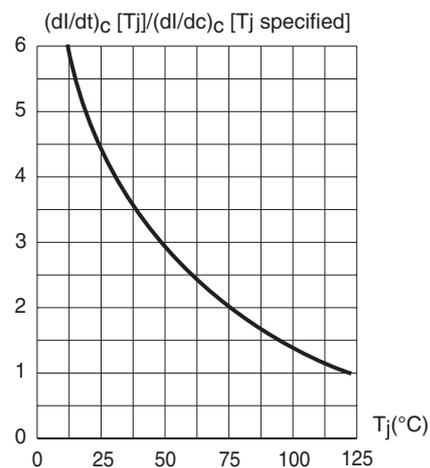
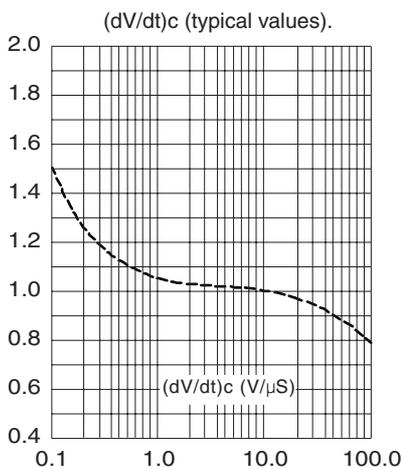


Fig. 9: Relative variation of critical rate of decrease of main current versus (dV/dt)c (typical values).



INSULATED LOGIC LEVEL TRIAC

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